

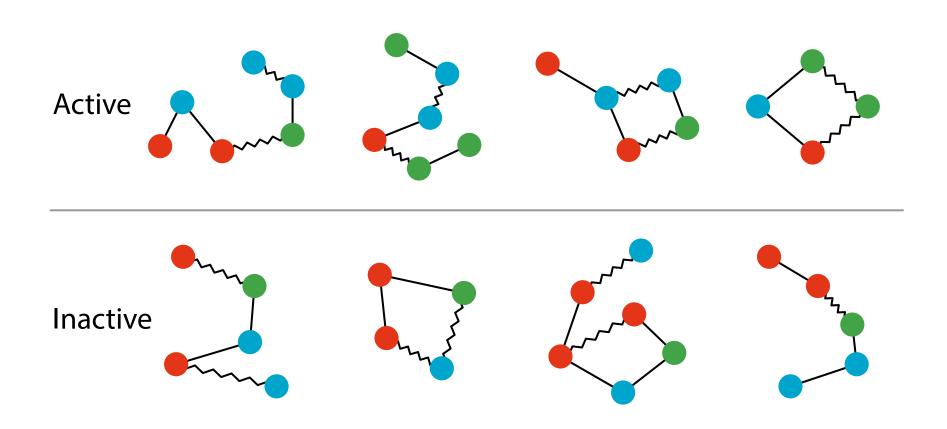
Significant Subgraph Mining with Multiple Testing Correction

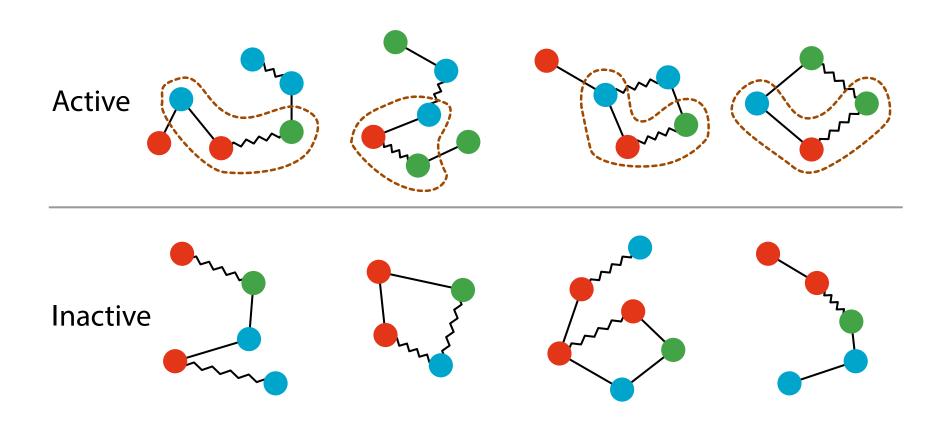
Mahito Sugiyama (Osaka University, JST PRESTO)

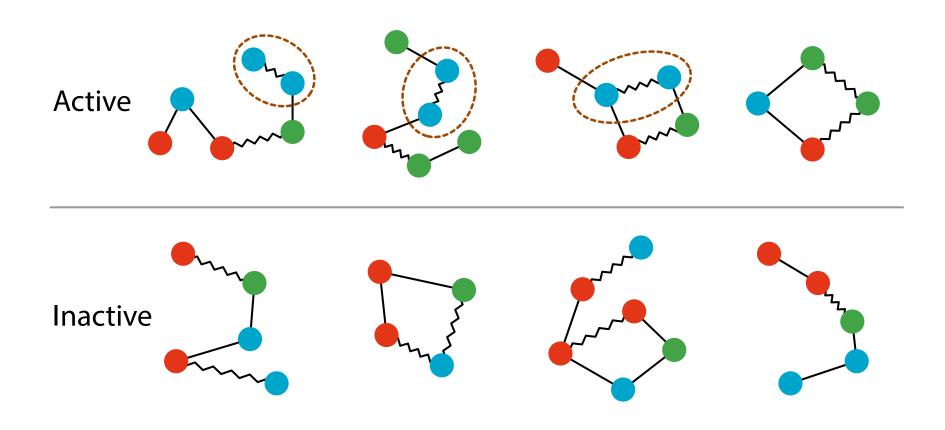
Joint work with Felipe Llinares López¹, Niklas Kasenburg², Karsten Borgwardt¹ (¹ETH Zürich, ²Univ. Copenhagen)

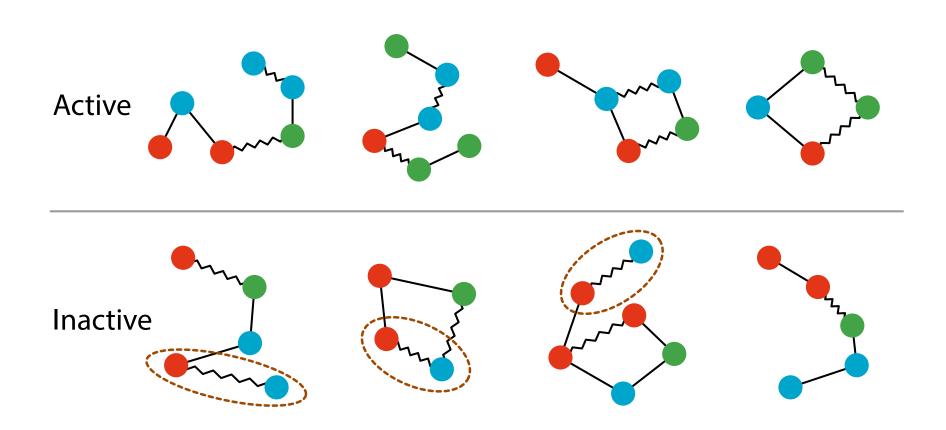
Summary

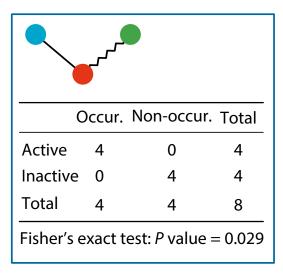
- Problem: Given a collection of graphs with class labels, find all subgraphs whose occurrences are significantly enriched in a particular class
 - A central step for deep understanding
- **Difficulty:** The number of subgraphs is massive (often more than a billion!)
 - Computationally expensive
 - Need of multiple testing correction to control false positive rate
- Solution: Only examining testable subgraphs
 - The number of candidate subgraphs dramatically reduced
 - Rigorous multiple testing correction



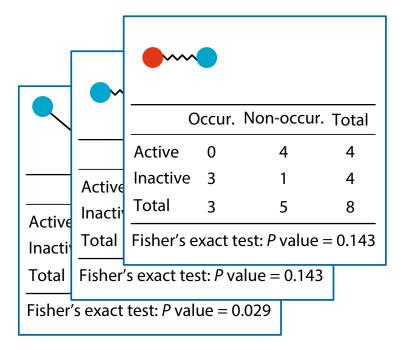


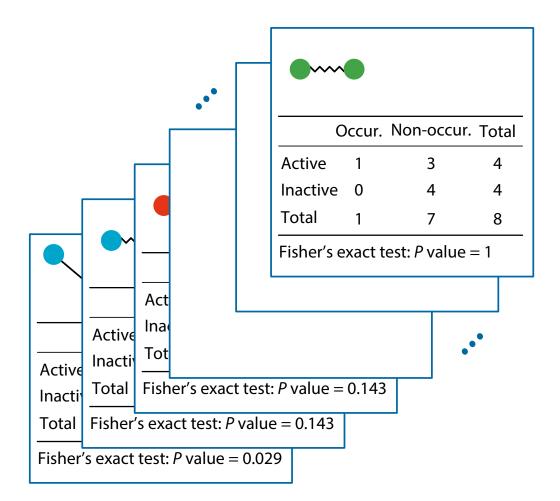


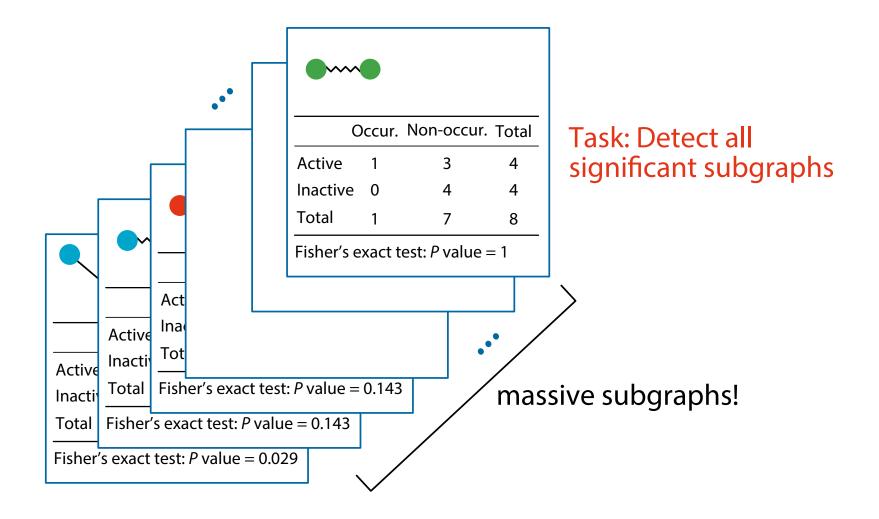




	0	ccur.	Non-occur.	Total	
	Active	3	1	4	
Active	Inactive	0	4	4	
Inacti	Total	3	5	8	
Total	Fisher's exact test: P value = 0.143				
Fisher's exact test: <i>P</i> value = 0.029					



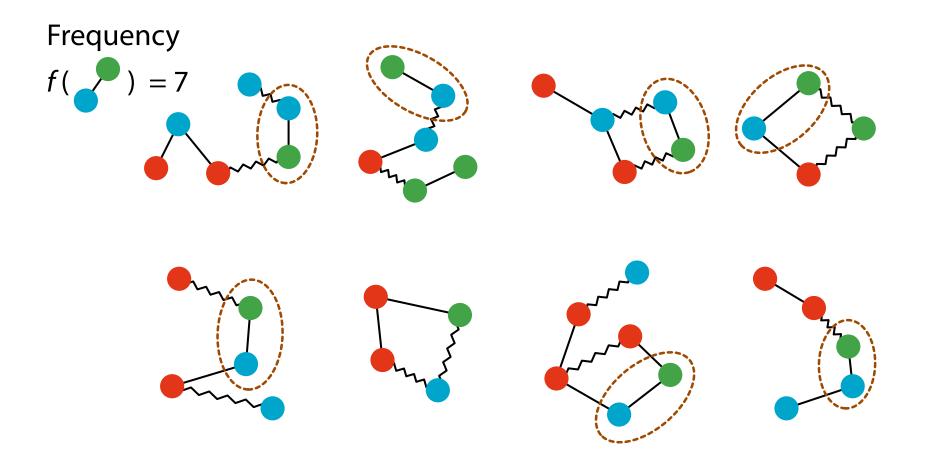




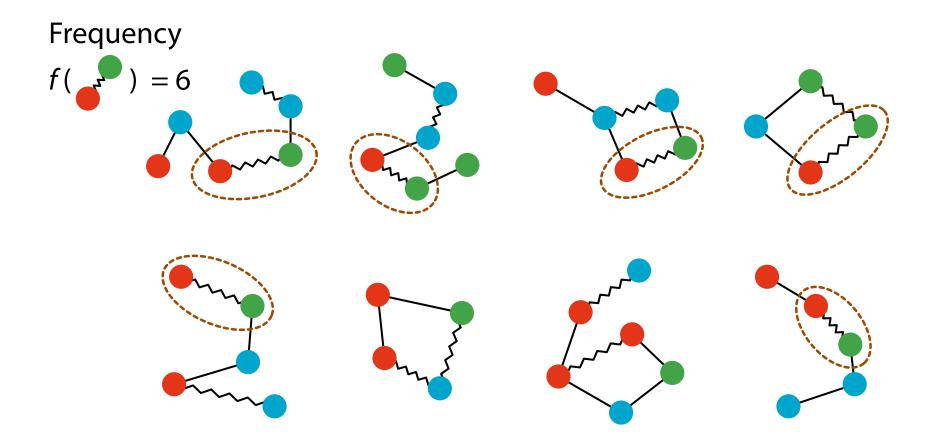
Multiple Testing Correction

- If we test *m* subgraphs, *αm* subgraphs are false positives
 - α : Significance level (predetermined by the user)
- FWER: Probability of having more than one false positives among all subgraphs
 - FWER = Pr(FP > o)
 - FP: Number of false positives
- To achieve FWER = α , change the significance level for each test from α to δ
 - δ : corrected significance level
 - $-\delta \leq \alpha$
 - Bonferroni correction is popular: $\delta_{Bon}^* = \alpha/m$

Counting the Frequency of Subgraphs



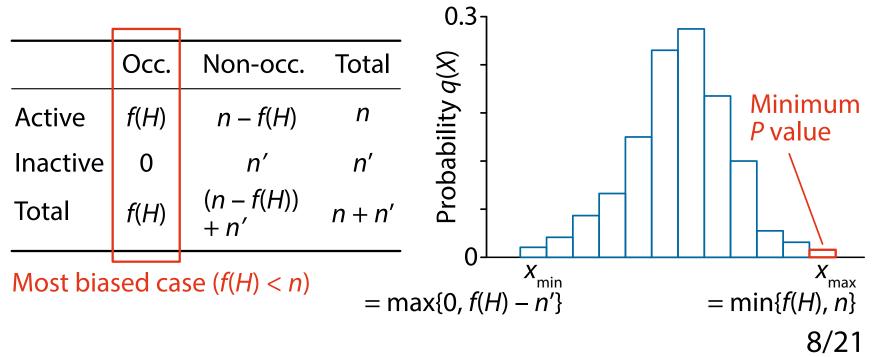
Counting the Frequency of Subgraphs



The Minimum P Value

 The minimum achievable *P* value is determined from the frequency *f*(*H*) of a subgraph *H*:

$$P_{\min} = \binom{n}{f(H)} / \binom{n+n'}{f(H)}$$



Testability

• The minimum achievable *P* value is determined from the frequency *f*(*H*) of a subgraph *H*:

$$P_{\min} = \binom{n}{f(H)} / \binom{n+n'}{f(H)}$$

- Tarone (1990) pointed out (and Terada et al. (2013) revisited): For a hypothesis H, if its minimum P value is larger than the significance threshold, this is untestable and we can ignore it
 - Untestable hypotheses (subgraphs) do not increase the FWER
 - The Bonferroni factor reduces to the number of testable hypotheses

Finding the Optimal Correction Factor

- m(k): # of subgraphs whose minimum P values < α/k
 k: the correction factor, α/k: the corrected significance level
- For each *k*, FWER is controlled as (Tarone 1990):

$$\mathsf{FWER} \le m(k)\frac{\alpha}{k} = \frac{m(k)}{k}\alpha$$

• Our task is to optimize k:

$$k^* = \underset{k}{\operatorname{argmax}} m(k) \quad \text{s.t. } m(k) \le k$$

– Enumerate testable subgraphs whose min. *P* values $< \alpha/k^*$

$$\delta^*_{Bon} = \alpha/(\# \text{ of all subgraphs})$$

 $\delta^*_{Tar} = \alpha/(\# \text{ of testable subgraphs})$

Subgraphs Are Testable Iff Frequent

• Our task:

$$k^* = \underset{k}{\operatorname{argmax}} m(k) \quad \text{s.t. } m(k) \le k$$

- m(k) = # of subgraphs whose minimum P values < a/k

Subgraphs Are Testable Iff Frequent

• Our task:

$$k^* = \underset{k}{\operatorname{argmax}} m(k) \quad \text{s.t. } m(k) \le k$$

$$\sigma^* = \operatorname*{argmax}_{\sigma} m'(\sigma) \quad \text{s.t. } m'(\sigma) \le \alpha/\psi(\sigma)$$

- -m(k) = # of subgraphs whose minimum *P* values $< \alpha/k$
- m'(σ): # of subgraphs whose frequency ≥ σ
 o # of "frequent subgraphs"

-
$$\psi(\sigma)$$
: the minimum *P* value at σ , $\psi(\sigma) = \binom{n}{\sigma} / \binom{n+n'}{\sigma}$

Subgraphs Are Testable Iff Frequent

• Our task:

$$k^* = \operatorname*{argmax}_k m(k) \quad \text{s.t. } m(k) \le k$$
 \Downarrow

$$\sigma^* = \operatorname*{argmax}_{\sigma} m'(\sigma) \quad \text{s.t. } m'(\sigma) \le \alpha/\psi(\sigma)$$

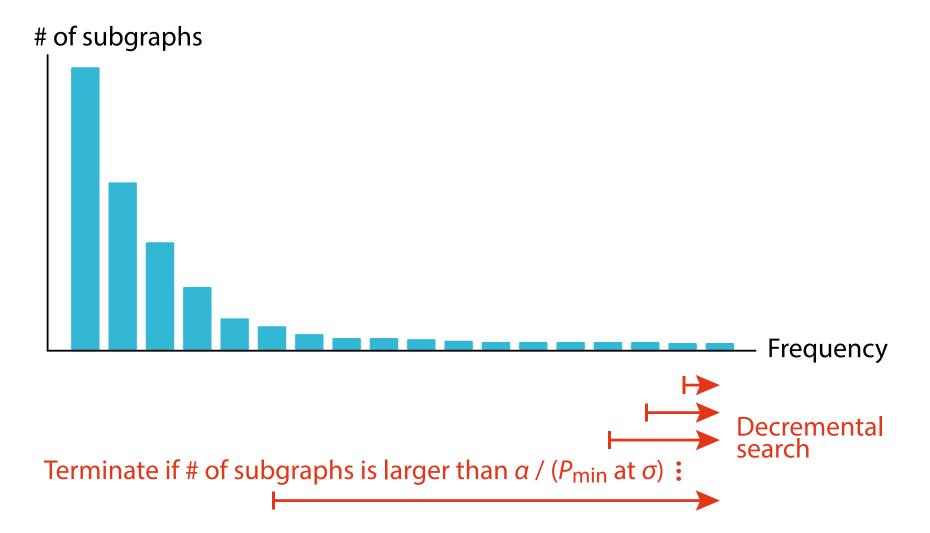
- -m(k) = # of subgraphs whose minimum *P* values $< \alpha/k$
- $-m'(\sigma)$: # of subgraphs whose frequency ≥ σ ∘ # of "frequent subgraphs"
- $\psi(\sigma)$: the minimum *P* value at σ , $\psi(\sigma) = \binom{n}{\sigma} / \binom{n+n'}{\sigma}$

Testable subgraphs = Frequent subgraphs

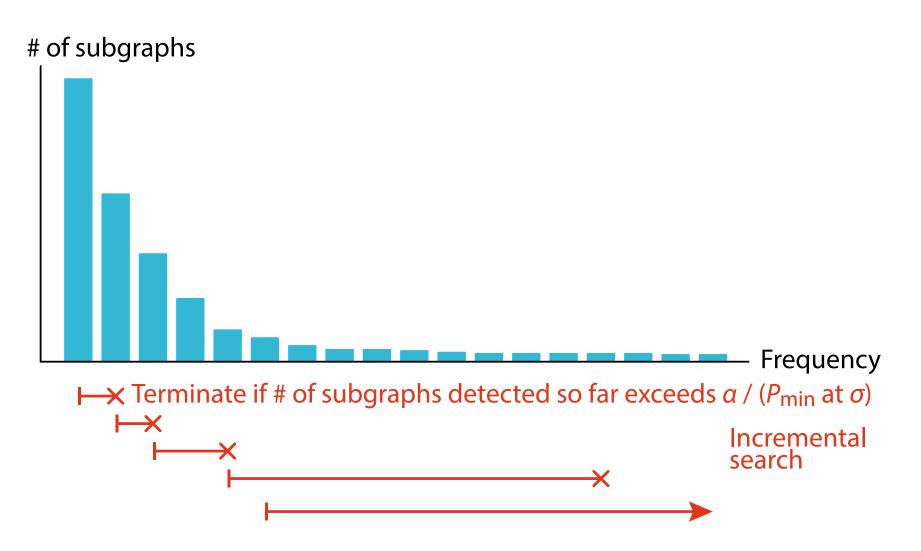
How to Use Subgraph Mining

of subgraphs

Decremental Search (LAMP)



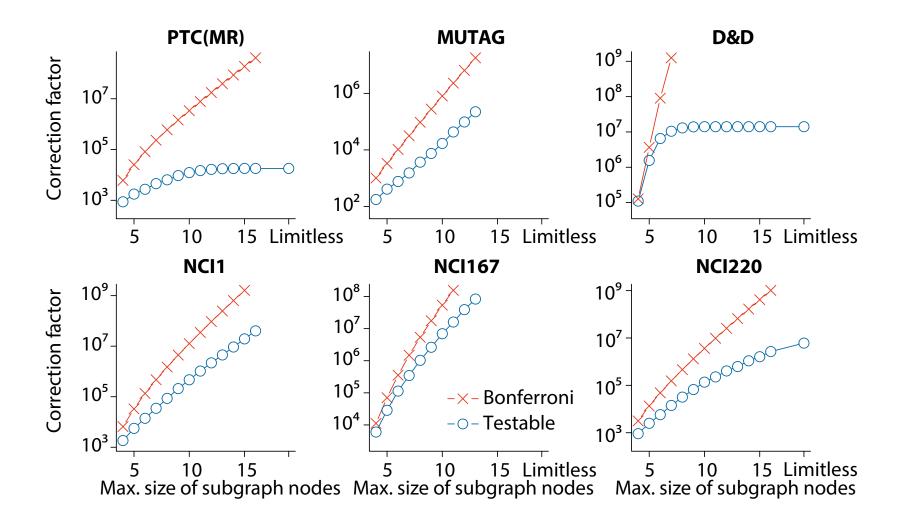
Incremental Search



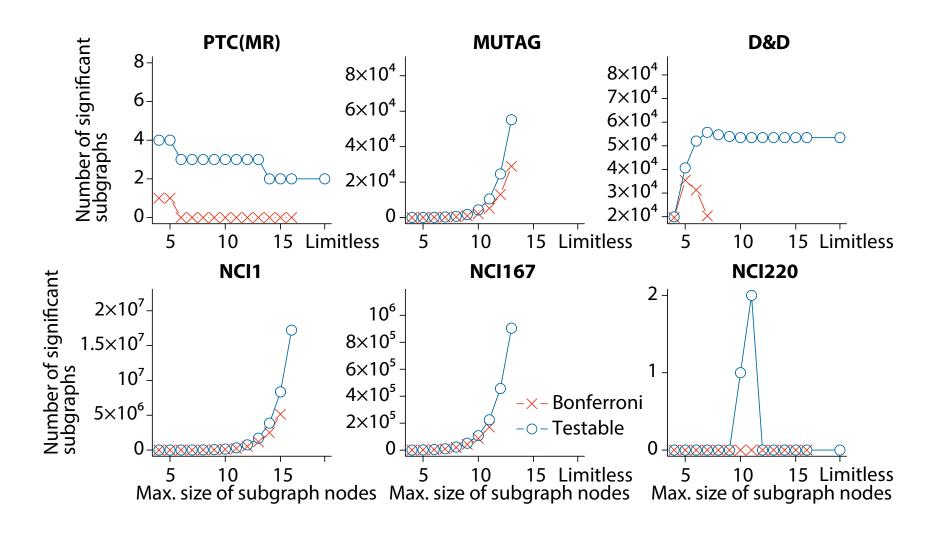
Datasets

Dataset	Size	#positive	avg. V	avg. E	max V	max E
PTC (MR)	584	181	31.96	32.71	181	181
MUTAG	188	125	17.93	39.59	28	66
D&D	1178	691	284.32	715.66	5748	14267
NCI1	4208	2104	60.12	62.72	462	468
NCI167	80581	9615	39.70	41.05	482	478
NCI220	900	290	46.87	48.52	239	255

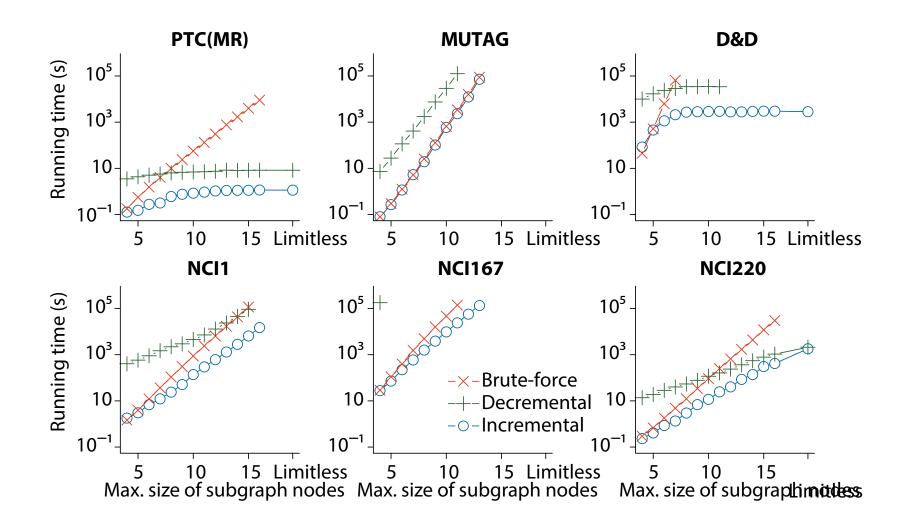
Correction Factor



Number of Significant Subgraphs



Running Time (second)



Running Time Summary

 RMSD (root mean square deviation) of running time (seconds) to the best (fastest) running time on all datasets

Brute-force	Decremental (LAMP)	Incremental
6.994 × 10 ⁴	2.410×10^{4}	1.230 × 10 ²

- Incremental search is the fastest
 - More than two orders of magnitude faster than brute-force
 - Much faster than decremental (LAMP) as the final minimum support is usually small (~20)

Final Minimum Frequencies

Dataset	Maximum size of subgraph nodes				n			
	5	7	9	11	13	15	Limitless	
PTC(MR)	9	10	11	11	11	11	11	181
MUTAG	8	10	11	12	14		—	125
D&D	20	22	22	22	22	22	22	691
NCI1	17	20	22	25	27	29		2104
NCI167	7	8	9	10	11			9615
NCI220	10	11	13	14	15	16	18	290

Conclusion

- We achieved to enumerate all significant subgraphs
 - The first work that considers multiple testing correction in graph mining
- Efficient and more powerful (less false negatives) using testability and frequent subgraph mining
- Pattern mining, a classical yet central topic in data mining, can be enriched by introducing statistical assessment
 - Can be applied in scientific fields such as biology

Appendix

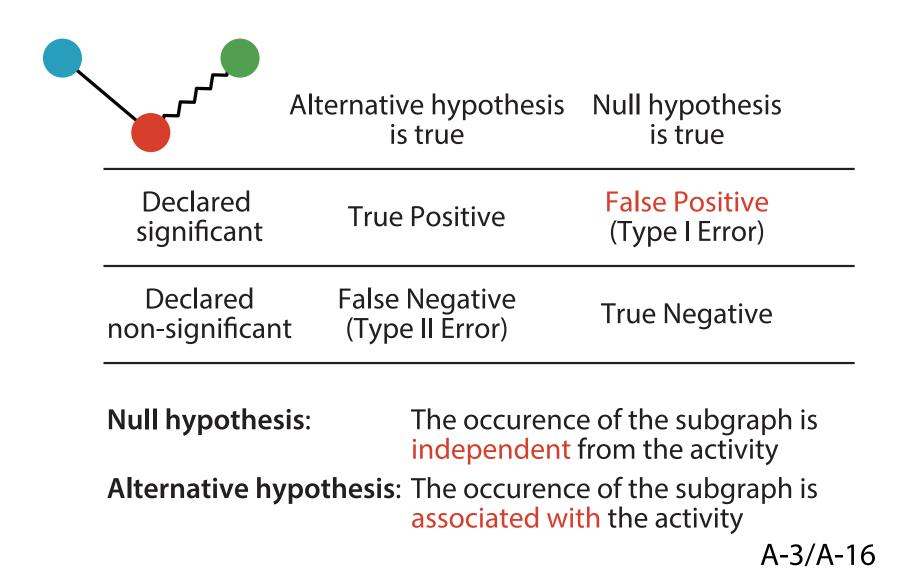


Papers about Testability

- Tarone, R.E.: A modified Bonferroni method for discrete data Biometrics (1990)
- Terada, A., Okada-Hatakeyama, M., Tsuda, K., Sese, J.: Statistical significance of combinatorial regulations, Proc. Natl. Acad. Sci. USA (2013).
- Minato, S., Uno, T., Tsuda, K., Terada, A., Sese, J.: Fast Statistical Assessment for Combinatorial Hypotheses Based on Frequent Itemset Mining ECML PKDD 2014
- Sugiyama, M., Llinares, F., Kasenburg, N., Borgwardt, K.: Significant Subgraph Mining with Multiple Testing Correction, SIAM SDM 2015 (http://arxiv.org/abs/1407.0316)
 - Code: http://git.io/N126

A-2/A-16

Hypothesis Test for Each Subgraph



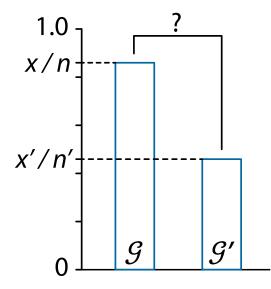
Testing the Independence of Subgraph

- Given two sets of graphs ${\mathcal G}$ and ${\mathcal G}'$

$$- |\mathcal{G}| = n, |\mathcal{G}'| = n' (n \le n')$$

The *P* value of each subgraph *H* ⊑ *G* with *G* ∈ *G* ∪ *G*' is determined by the Fisher's exact test

	Occ.	Non-occ.	Total
${\mathcal G}$	X	n-x	n
\mathcal{G}'	Χ'	n'-x'	n'
Total	<i>x</i> + <i>x</i> ′	(n – x) + (n′ – x′)	n + n'

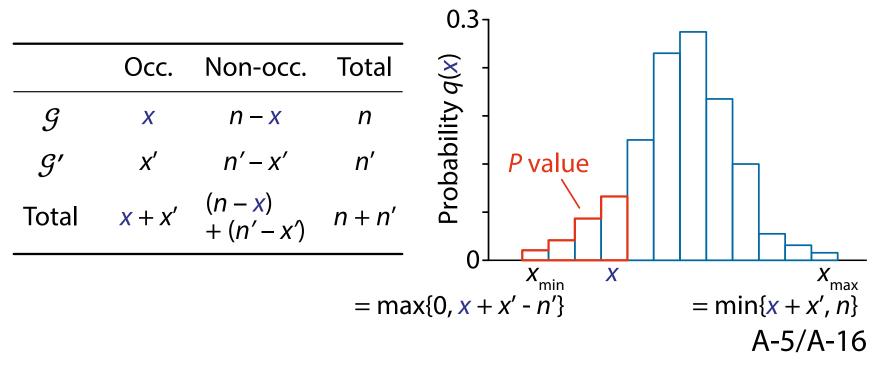


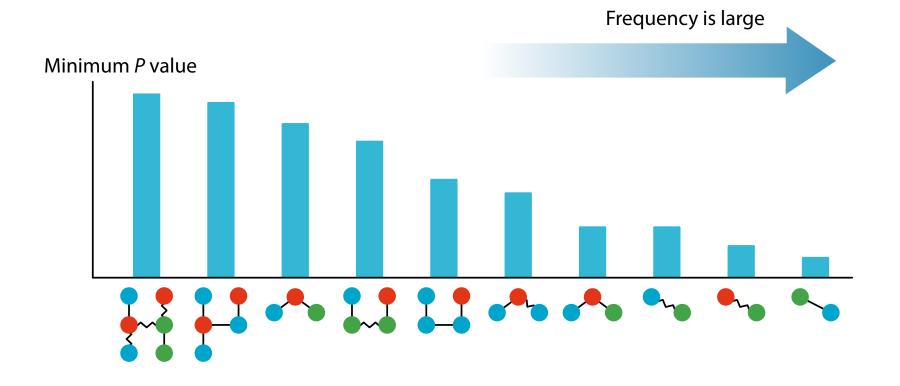
A-4/A-16

Fisher's Exact Test

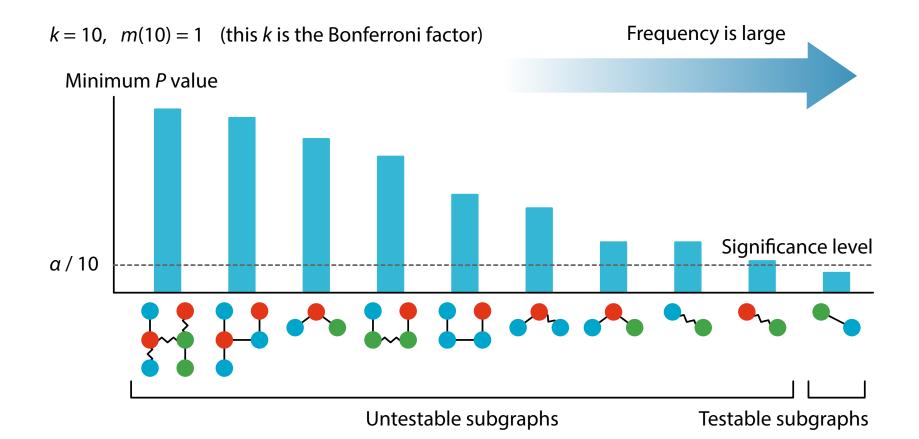
 The probability q(x) of obtaining x and x' is given by the hypergeometric distribution:

$$q(\mathbf{x}) = \binom{n}{\mathbf{x}}\binom{n'}{\mathbf{x}'} / \binom{n+n'}{\mathbf{x}+\mathbf{x}'}$$

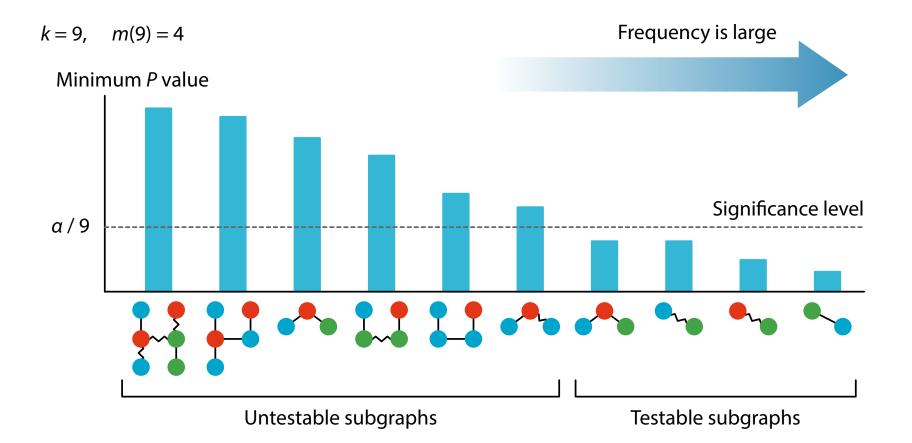




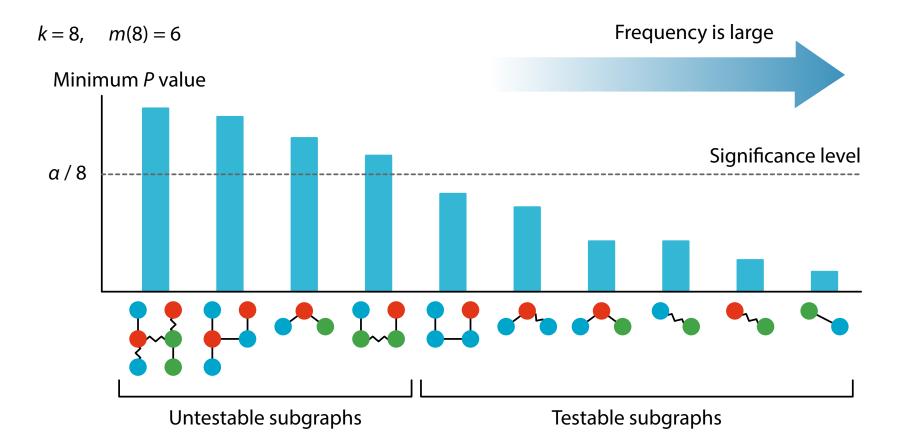
A-6/A-16



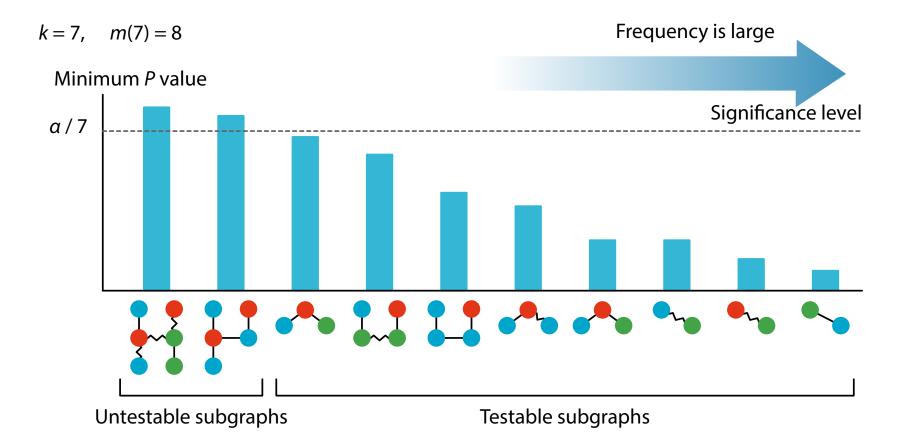
A-7/A-16



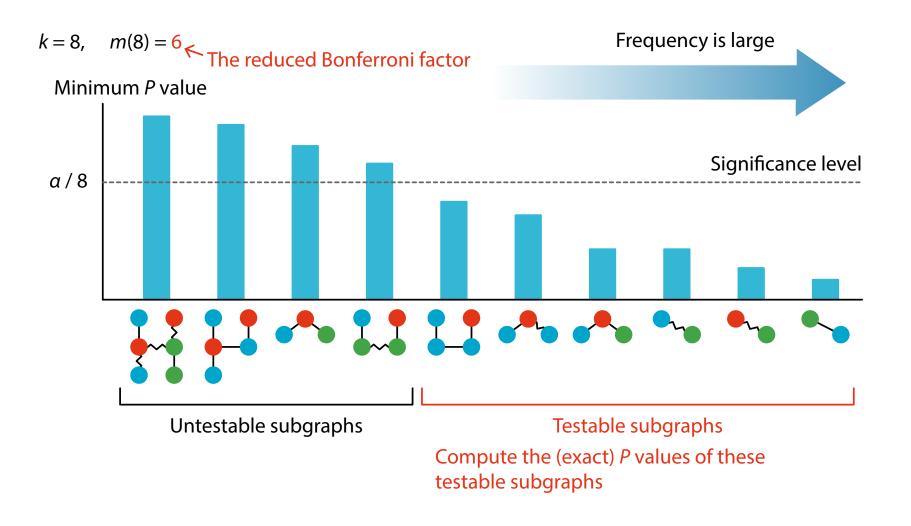
A-8/A-16



A-9/A-16



A-10/A-16



A-11/A-16

Effective Number of Tests

- Many subgraphs are expected to be highly correlated due to subgraph-supergraph relationships
- Use the effective number of tests to exploit the dependence between subgraphs and increase the power
- In the **Šidák correction**, the significance level

$$a' = 1 - (1 - a)^{1/m}$$

for *m* independent tests

• Only $m_{\text{eff}} < m$ tests are effective for controlling the FWER $m_{\text{eff}} := \frac{\log(1 - \alpha)}{\log(1 - \alpha')}$

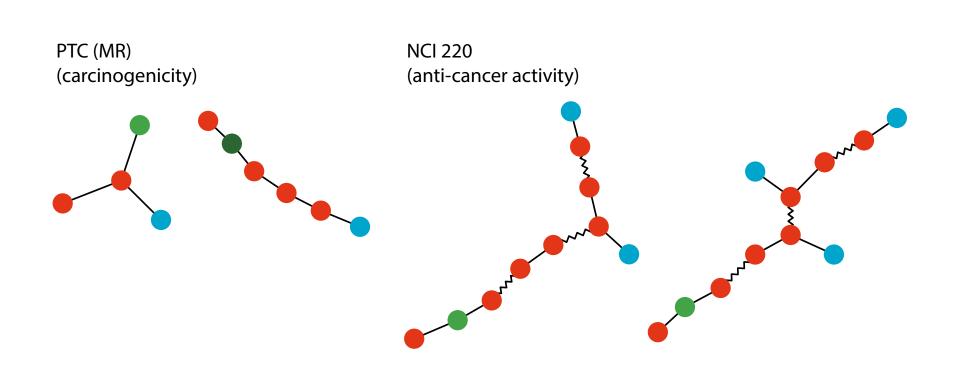
A-12/A-16

Estimation of Effective Number

- We directly estimate the level α' by random permutations of class labels
 - Optimal estimation of $m_{\rm eff}$ in theory
 - The drawback is the high computational cost O(mh)
 m: # of subgraphs, h: # of iterations
- Overcome by considering only testable subgraphs
 - We apply the above permutation-based estimation to only testable subgraphs
 - The complexity is $O(\tau(m)h)(\tau(m): \# \text{ of testable subgraphs})$
- Moskvina, V. and Schmidt, K. M. On multiple-testing correction in genome-wide association studies. *Genetic epidemiology*, 32(6):567–573, 2008.

A-13/A-16

Detected Significant Subgraphs



A-14/A-16

Frequent Subgraph Miners

- [AGM] Inokuchi, A. and Washio, T. and Motoda, H.: An Apriori-Based Algorithm for Mining Frequent Substructures from Graph Data, PKDD 2000
- [gSpan] Yan, X. and Han, J.: gSpan: Graph-based substructure pattern mining, ICDM 2002
- [GASTON] Nijssen, S. and Kok, J. N.: A Quickstart in Frequent Structure Mining Can Make a Difference, KDD 2004
- (comparison) Wörlein, M. and Meinl, T. and Fischer, I. and Philippsen, M.
 A Quantitative Comparison of the Subgraph Miners MoFa, gSpan, FFSM, and Gaston, PKDD 2005
 - We used GASTON as it is the fastest

Related work: LAMP version 2

- Minato et al. proposed a faster version of LAMP in itemset mining
 - Minato, S., Uno, T., Tsuda, K., Terada, A. and Sese, J.: Fast Statistical Assessment for Combinatorial Hypotheses Based on Frequent Itemset Mining ECML PKDD 2014
- The idea is almost the same with our incremental search
 - Start from $\sigma = 1$, every time an item is added, the condition $|\mathcal{I}(\sigma)| \le \alpha/\psi(\sigma)$ is checked

• $\mathcal{I}(\sigma)$: the set of itemsets found so far with the frequency $\geq \sigma$

- As soon as $|\mathcal{I}(\sigma)| > \alpha/\psi(\sigma)$, the current σ is too large and we decrement it